

Description

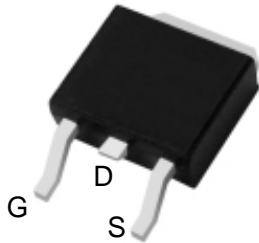
ELV688R0ND N-channel Enhancement Mode Power MOSFET

Features

- 68V, 85A
- $R_{DS(ON)}=8.0m\Omega @ V_{GS}=10V$
- Advanced Trench Technology
- Provide Excellent $R_{DS(ON)}$ and Low Gate Charge
- Lead free product is acquired

Application

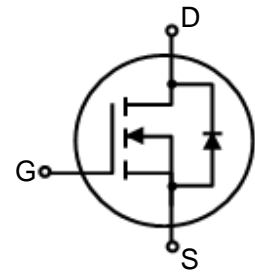
- Load Switch
- PWM Application
- Power management



TO-252 top view



Marking and pin Assignment



Schematic Diagram

Package Marking and Ordering Information

| Device Marking | Device | OUTLINE | Device Package | TUBE (PCS) | Inner BOX (PCS) | Per Carton (PCS) |
|----------------|------------|---------|----------------|------------|-----------------|------------------|
| ELV688R0ND | ELV688R0ND | TAPING | TO-252 | 13inch | 2500 | 25000 |

Absolute Maximum Ratings ($T_C=25^\circ C$ unless otherwise specified)

| Symbol | Parameter | Max. | Units |
|-----------------|---|---------------------|--------------|
| V_{DSS} | Drain-Source Voltage | 68 | V |
| V_{GSS} | Gate-Source Voltage | ± 20 | V |
| I_D | Continuous Drain Current | $T_C = 25^\circ C$ | 85 |
| | | $T_C = 100^\circ C$ | 60 |
| I_{DM} | Pulsed Drain Current ^{note1} | 340 | A |
| E_{AS} | Single Pulsed Avalanche Energy ^{note2} | 182 | mJ |
| P_D | Power Dissipation | $T_C = 25^\circ C$ | 125 |
| $R_{\theta JC}$ | Thermal Resistance, Junction to Case | 1.0 | $^\circ C/W$ |
| T_J, T_{STG} | Operating and Storage Temperature Range | -55 to +150 | $^\circ C$ |

Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise specified)

| Symbol | Parameter | Test Condition | Min. | Typ. | Max. | Units |
|---------------------------|---------------------------------|-----------------------------|------|------|-----------|---------|
| Off Characteristic | | | | | | |
| $V_{(BR)DSS}$ | Drain-Source Breakdown Voltage | $V_{GS}=0V, I_D=250\mu A$ | 68 | - | - | V |
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{DS}=68V, V_{GS}=0V,$ | - | - | 1.0 | μA |
| I_{GSS} | Gate to Body Leakage Current | $V_{DS}=0V, V_{GS}=\pm 20V$ | - | - | ± 100 | nA |

| | | | | | | |
|---------------------------|---|-------------------------------|---|-----|-----|------------|
| On Characteristics | | | | | | |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{DS}=V_{GS}, I_D=250\mu A$ | 2 | - | 4 | V |
| $R_{DS(on)}$ | Static Drain-Source on-Resistance <small>note3</small> | $V_{GS}=10V, I_D=40A$ | - | 8.0 | 9.1 | m Ω |

| | | | | | | |
|--------------------------------|------------------------------|--|---|------|---|----|
| Dynamic Characteristics | | | | | | |
| C_{iss} | Input Capacitance | $V_{DS}=34V, V_{GS}=0V,$ $f=1.0MHz$ | - | 3704 | - | pF |
| C_{oss} | Output Capacitance | | - | 231 | - | pF |
| C_{rss} | Reverse Transfer Capacitance | | - | 219 | - | pF |
| Q_g | Total Gate Charge | $V_{DS}=54V, I_D=30A,$ $V_{GS}=10V$ | - | 80 | - | nC |
| Q_{gs} | Gate-Source Charge | | - | 20 | - | nC |
| Q_{gd} | Gate-Drain("Miller") Charge | | - | 31 | - | nC |

| | | | | | | |
|----------------------------------|---------------------|---|---|----|---|----|
| Switching Characteristics | | | | | | |
| $t_{d(on)}$ | Turn-on Delay Time | $V_{DS}=34V, I_D=30A,$ $R_{GEN}=4.7\Omega, V_{GS}=10V$ | - | 22 | - | ns |
| t_r | Turn-on Rise Time | | - | 61 | - | ns |
| $t_{d(off)}$ | Turn-off Delay Time | | - | 67 | - | ns |
| t_f | Turn-off Fall Time | | - | 28 | - | ns |

| | | | | | | |
|---|--|---|---|-----|-----|----|
| Drain-Source Diode Characteristics and Maximum Ratings | | | | | | |
| I_S | Maximum Continuous Drain to Source Diode Forward Current | - | - | 85 | - | A |
| I_{SM} | Maximum Pulsed Drain to Source Diode Forward Current | - | - | 340 | - | A |
| V_{SD} | Drain to Source Diode Forward Voltage | $V_{GS}=0V, I_S=45A$ | - | - | 1.4 | V |
| t_{rr} | Body Diode Reverse Recovery Time | $T_J=25^\circ\text{C}$ $I_F=30A, di/dt=100A/\mu s$ | - | 35 | - | ns |
| Q_{rr} | Body Diode Reverse Recovery Charge | | - | 44 | - | nC |

- Notes: 1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature
 2. EAS condition: $T_J=25^\circ\text{C}, V_{DD}=50V, V_G=10V, R_G=25\Omega, L=0.5mH, I_{AS}=27A$
 3. Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$

Typical Performance Characteristics

Figure 1: Output Characteristics

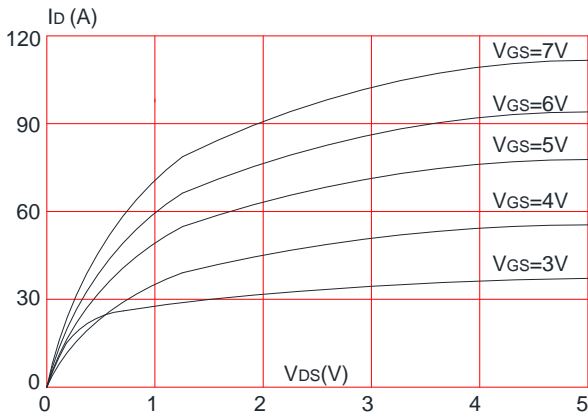


Figure 2: Typical Transfer Characteristics

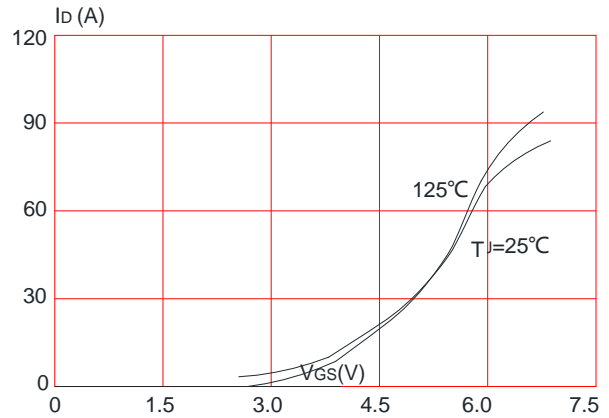


Figure 3: On-resistance vs. Drain Current

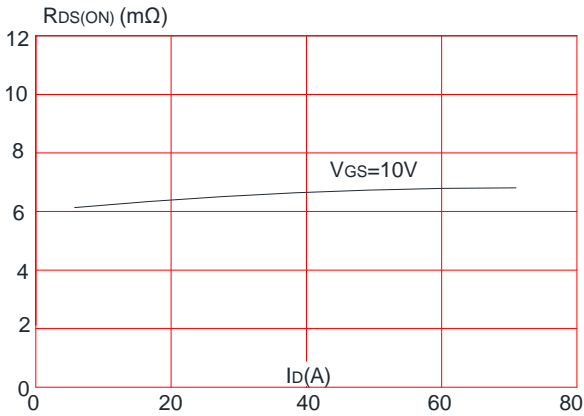


Figure 4: Body Diode Characteristics

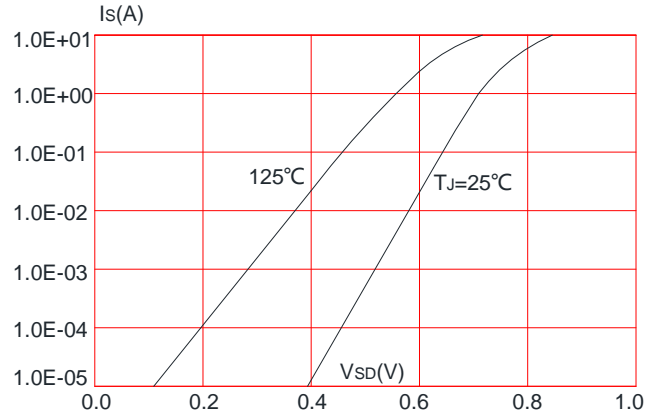


Figure 5: Gate Charge Characteristics

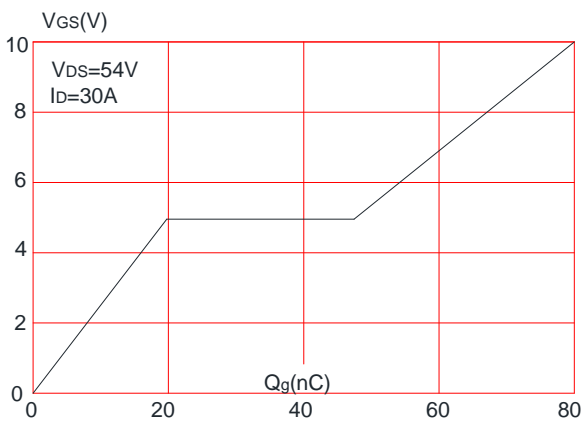


Figure 6: Capacitance Characteristics

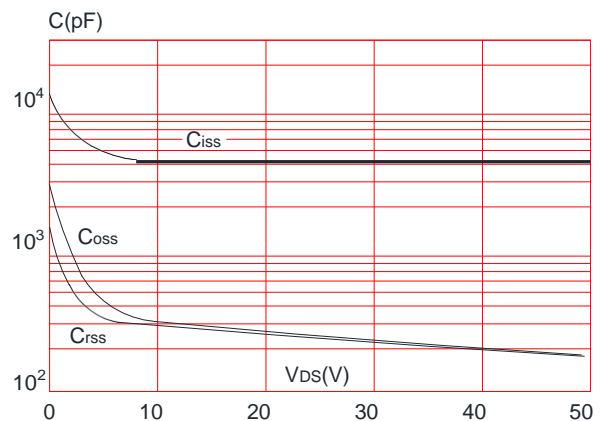


Figure 7: Normalized Breakdown Voltage vs. Junction Temperature

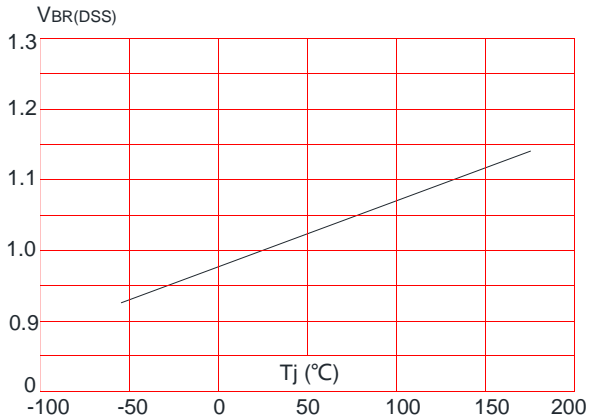


Figure 8: Normalized on Resistance vs. Junction Temperature

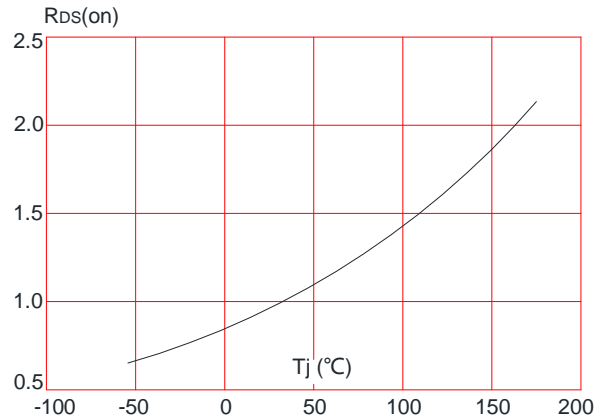


Figure 9: Maximum Safe Operating Area

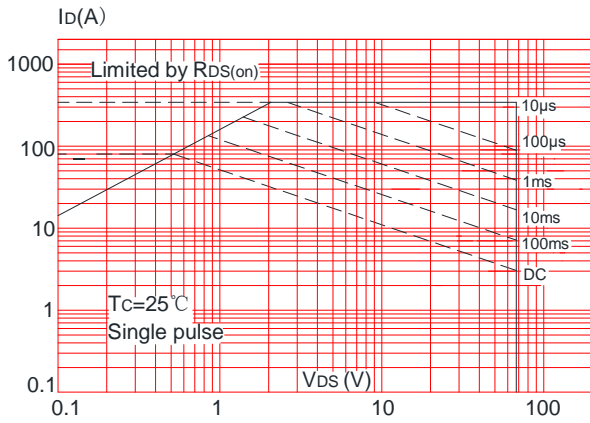


Figure 10: Maximum Continuous Drain Current vs. Case Temperature

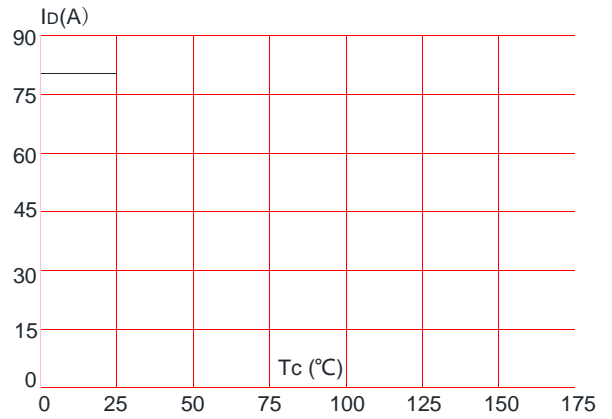
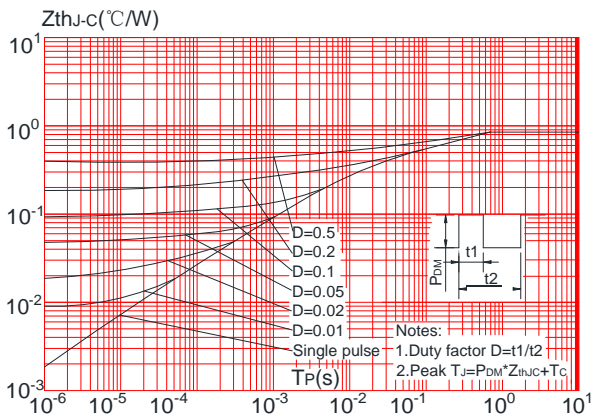


Figure.11: Maximum Effective Transient Thermal Impedance, Junction-to-Case



Test Circuit

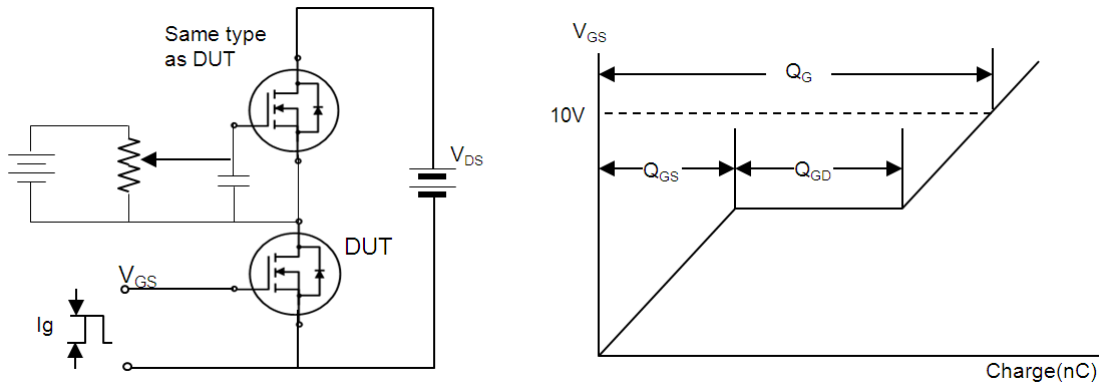


Figure1:Gate Charge Test Circuit & Waveform

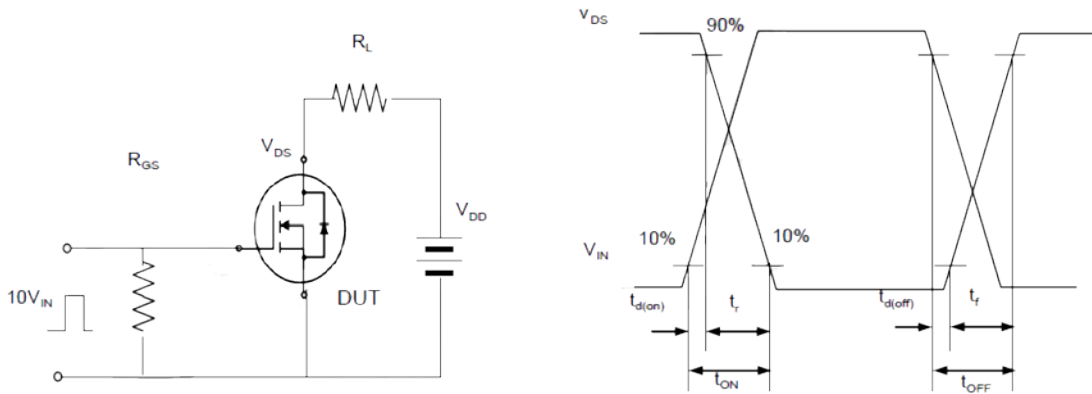


Figure 2: Resistive Switching Test Circuit & Waveforms

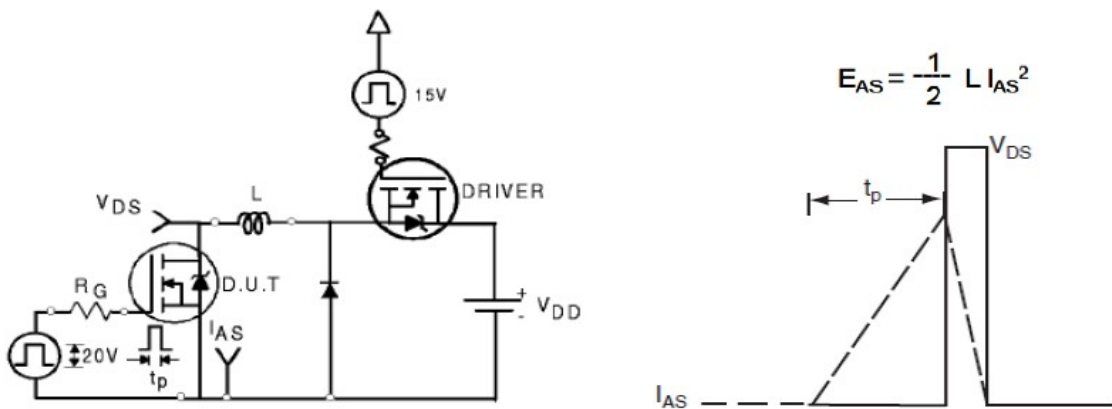
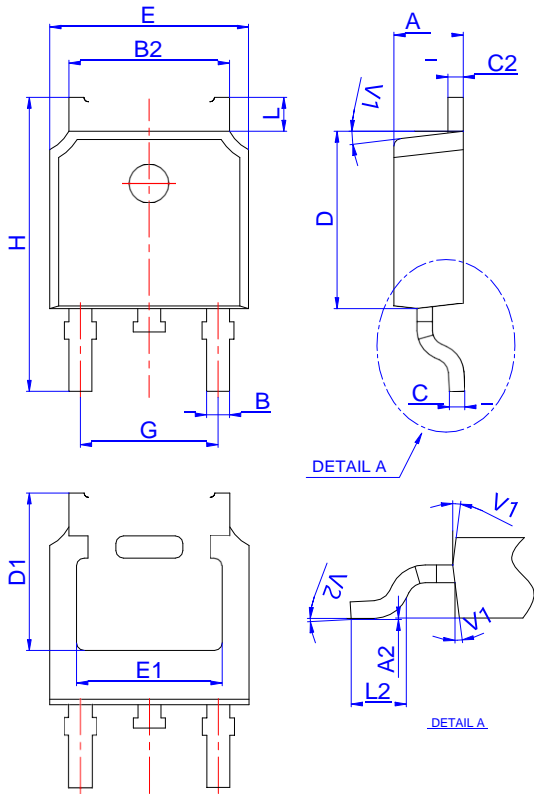


Figure 3:Unclamped Inductive Switching Test Circuit & Waveforms

Package Mechanical Data-TO-252



| Ref. | Dimensions | | | | | |
|------|-------------|------|-------|----------|------|-------|
| | Millimeters | | | Inches | | |
| | Min. | Typ. | Max. | Min. | Typ. | Max. |
| A | 2.10 | | 2.50 | 0.083 | | 0.098 |
| A2 | 0 | | 0.10 | 0 | | 0.004 |
| B | 0.66 | | 0.86 | 0.026 | | 0.034 |
| B2 | 5.18 | | 5.48 | 0.202 | | 0.216 |
| C | 0.40 | | 0.60 | 0.016 | | 0.024 |
| C2 | 0.44 | | 0.58 | 0.017 | | 0.023 |
| D | 5.90 | | 6.30 | 0.232 | | 0.248 |
| D1 | 5.30REF | | | 0.209REF | | |
| E | 6.40 | | 6.80 | 0.252 | | 0.268 |
| E1 | 4.63 | | | 0.182 | | |
| G | 4.47 | | 4.67 | 0.176 | | 0.184 |
| H | 9.50 | | 10.70 | 0.374 | | 0.421 |
| L | 1.09 | | 1.21 | 0.043 | | 0.048 |
| L2 | 1.35 | | 1.65 | 0.053 | | 0.065 |
| V1 | | 7° | | | 7° | |
| V2 | 0° | | 6° | 0° | | 6° |

Product Naming Rules

